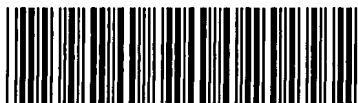


**Search Notes**

Application/Control No.

10/676,258

Examiner

B. Chen

Applicant(s)/Patent under  
Reexamination

MIYANO ET AL.

Art Unit

1762

**SEARCHED**

Class	Subclass	Date	Examiner
427	595 596	4/11/2007	BC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
427	595 596	4/11/2007	BC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	4/9/2007	BC
discussed east search with Examiner Talbot	4/10/2007	BC